## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination CHAPUIS, ALAIN Examiner | Art Unit | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2005/0093594 A1	05-2005	Kim et al.	327/158
	В	US-			
	С	US-	·		
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification		
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## **NON-PATENT DOCUMENTS**

	NOTE ALLEY DOCUMENTO							
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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